Sajid Ali

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Education

2016-Present Northwestern University, Evanston, IL,

Ph.D., Applied Physics,

Computational x-ray optics, Technique development for X-ray Microscopy.

2011–2016 **IIT Madras**, Chennai, India,

Masters of Tech. in Microelectronics and VLSI Design Electrical Engg.,

Master's Thesis: Impurity induced magnetism in Graphene.

2011–2016 IIT Madras, Chennai, India,

Bachelors of Technology, Electrical Engg.,

Minor: Physics.

Professional Experience

Summer 2020 WJ Cody Associate,

Mathematics and Computer Science Division, Argonne National Laboratory, PI: Dr Wendy Di.

 \circ Improving the performance and scalability of a tomography reconstruction code written in C++/PETSc.

Research Experience

2018-Present X-Ray Wave Propagation,

X-Ray Microscopy Group, Northwestern University, PI: Prof Chris Jacobsen.

- Developing parallelized computer codes for large scale wave propagation.
- o Implemented finite difference based wave propagation in PETSc.

2016–2019 **Zone Plate Testing**,

X-Ray Microscopy Group, Northwestern University, PI: Prof Chris Jacobsen.

- Tested high aspect ratio zone plates for efficiency and tilt tolerance at APS and NSLS.
- Developed code to simluate the effect of tilt misalignment.

2015–2016 Magnetism in Graphene,

Computaional Condensed Matter Group, IIT Madras, PI: Prof Ranjit Nanda.

- o Investigated the magnetic properties of ntercalated bilayer graphene using DFT.
- Performed stability analysis for those which exhibited a non-trivial magnetic moment.

Publications

Tunable hard x-ray nanofocusing with Fresnel zone plates fabricated using deep etching Kenan Li, Sajid Ali, Michael Wojcik, Vincent De Andrade, Xiaojing Huang, Hanfei Yan, Yong S. Chu, Evgeny Nazaretski, Ajith Pattammattel, and Chris Jacobsen Optica Vol. 7, Issue 5, pp. 410-416 (2020)

2020 **Effect of tilt on circular zone plate performance** Sajid Ali and Chris Jacobsen *Journal of the Optical Society of America A Vol. 37, Issue 3, pp. 374-383 (2020)*